

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BISCARINI ET AL.	
		10/537,158	Examiner	Art Unit Elizabeth Whitehead
			1762	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/017272-0172072	11-2002	Chen et al.	365/151
*	B	US-6,827,979	12-2004	Mirkin et al.	427/256
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Cavallini et al., "Information Storage Using Supramolecular Surface Patterns", January 24, 2003, Science Magazine, Vol. 299, p. 531.
	V	Cavallini et al., "Conformational Self-Recognition as the Origin of Dewetting in Bistable Molecular Surfaces", October 11, 2001, American Chemical Society, J. Phys. Chem. B 2001, 105, 10826-10830.
	W	Michel et al. "Printing meets lithography: Soft approaches to high-resolution patterning", September 5, 2001, IBM, J. Res. Dev., Vol. 45, p. 697-719.
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.